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**Fine ceramics (advanced ceramics,  
advanced technical ceramics) —  
Determination of thermal diffusivity of  
monolithic ceramics by laser flash  
method**

**iTeh STANDARD PREVIEW**  
*Céramiques techniques — Détermination de la diffusivité thermique des  
céramiques monolithiques par la méthode flash laser*  
**(standards.iteh.ai)**

ISO 18755:2005

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## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO 18755 was prepared by Technical Committee ISO/TC 206, *Fine ceramics*.

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# Fine ceramics (advanced ceramics, advanced technical ceramics) — Determination of thermal diffusivity of monolithic ceramics by laser flash method

## 1 Scope

This International Standard specifies the test method for the determination of thermal diffusivity from room temperature to 1700 K by the laser flash method for homogeneous monolithic ceramics with porosity less than 10 %.

## 2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 3611, *Micrometer callipers for external measurement*

## 3 Terms and definitions

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For the purposes of this document, the following terms and definitions apply.

### 3.1

#### **thermal diffusivity**

thermal conductivity divided by the product of specific heat capacity and density

### 3.2

#### **thermal conductivity**

density of heat flow rate divided by temperature gradient under steady state condition

### 3.3

#### **specific heat capacity**

heat capacity per unit mass

### 3.4

#### **pulse width**

$\tau_p$   
full width of half maximum (FWHM) which is the time duration when the laser pulse intensity is larger than the half of its maximum value on time basis

### 3.5

#### **centroid of laser pulse**

chronological centroid of laser light energy

### 3.6

#### **spatial energy distribution of pulse heating**

energy density of the laser beam incident at each point on the front face of the specimen

**3.7**

**transient temperature curve**

transient temperature change of the rear face of the specimen after the light pulse heating

**3.8**

**transient radiance curve**

transient change of the spectral radiance from the rear face of the specimen after the light pulse heating

NOTE It should be noted that the observed transient curve is proportional to the change of the spectral radiance rather than the change of temperature when a radiation thermometer or a radiation detector is used to observe the transient temperature rise of the specimen after the light pulse heating.

**3.9**

**maximum temperature rise**

$\Delta T_{\max}$

difference between the steady temperature before the pulse heating and the maximum temperature of the rear face of the specimen after the pulse heating

NOTE See Figure 1.

**3.10**

**half rise-time**

$t_{1/2}$

time until  $\Delta T_{\max}/2$  is attained from the pulse heating

**3.11**

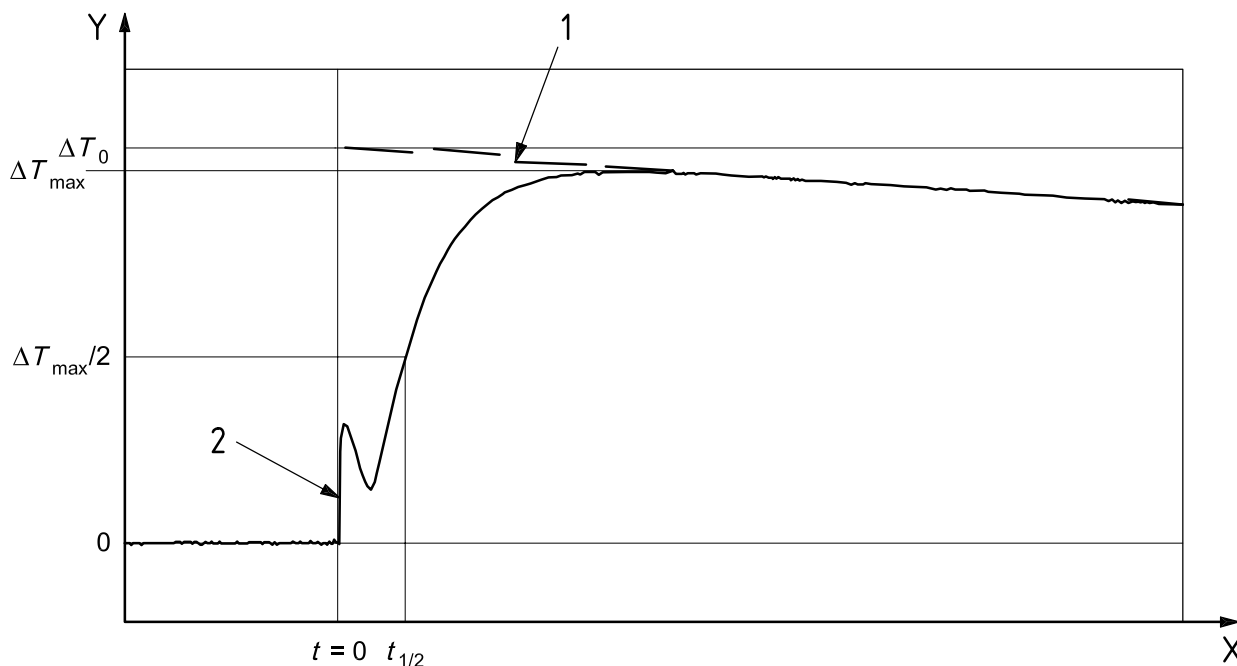
**characteristic time of heat loss**

$\tau_c$

time of heat loss determined when the cooling region is fitted with an exponential function,  $\Delta T_0 \exp(-t/\tau_c)$

NOTE See Figure 1.

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**Key**

X: time

Y: temperature rise

1 exponential function  $[\Delta T_0 \exp(-t/\tau_c)]$ 

2 initial noise

**Figure 1** — Transient temperature curve of the rear face of the specimen after a light pulse heating onto the front face of the specimen

**3.12****extrapolated temperature rise** $\Delta T_0$ temperature rise determined when the cooling region is fitted with an exponential function,  $\Delta T_0 \exp(-t/\tau_c)$ **3.13****initial noise superimposed on transient temperature curve**

initial spike and/or hump superimposed on the initial part of the transient temperature curve, due to transmitted and/or scattered light from the heating laser pulse and/or electrically induced noise associated with the laser pulse discharge

**3.14****homogeneity of specimen**

degree of homogeneity of local thermal diffusivity over the specimen

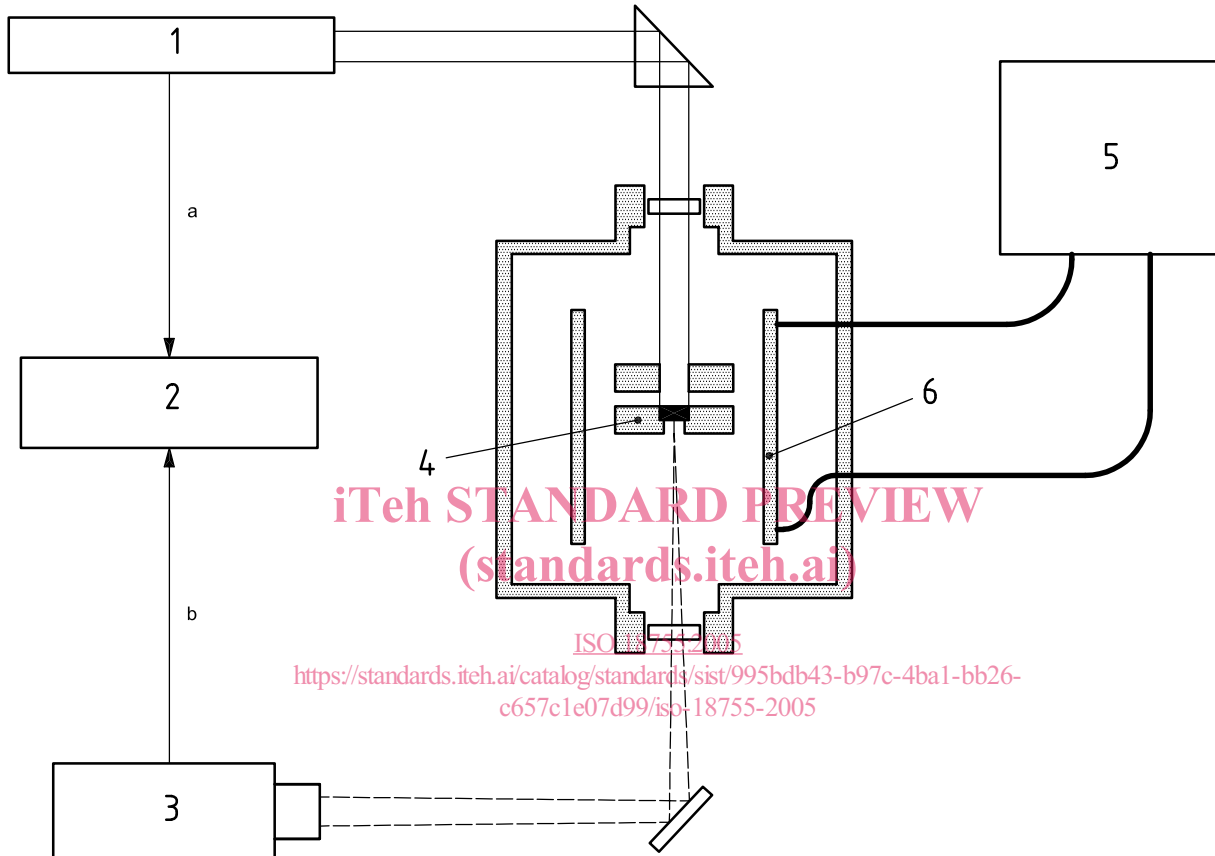
**4 Apparatus**

The apparatus shall be designed for obtaining the thermal diffusivity from the transient temperature curve of the rear face of a specimen after the laser pulse is irradiated onto the front face of the specimen, and shall consist of the following principal components as shown in Figure 2.

### 4.1 Specimen holder

The specimen holder shall hold the specimen stable, with minimum thermal contact, and shall be designed to suppress stray lights from the laser beam being transmitted to the transient detector.

A diaphragm with aperture diameter slightly larger than the specimen diameter should be placed close to the front face of the specimen, and another diaphragm with aperture diameter smaller than the specimen diameter and larger than the target size of radiative detection should be placed close to the rear face of the specimen.



**Key**

- |                 |                   |
|-----------------|-------------------|
| 1 pulsed laser  | 4 specimen holder |
| 2 data analysis | 5 power supply    |
| 3 detector      | 6 heater          |

- a Trigger signal.  
b Transient temperature response.

**Figure 2 — Block diagram of laser flash apparatus for measuring thermal diffusivity**

### 4.2 Pulse laser

The pulse laser shall be capable of emitting the light pulse with pulse duration preferably shorter than 1,0 ms in full width at half maximum (FWHM). The specimen should be irradiated uniformly by the light pulse.

When a pulse laser is used for the light pulse, the direct beam profile is often irregular because of multi-mode oscillation. In this case, the beam should be converted to a uniform beam using beam-homogenizing optics.



### 4.3 Thermometer for measuring steady-state temperature of the specimen

The steady-state temperature of the specimen before pulse heating should be measured by a thermocouple, or an equally or more reliable thermometer.

The thermocouple shall be positioned such that it does not interrupt the light pulse heating onto the front face of the specimen, or the radiation from the rear face of the specimen. If the specimen does not react with the thermocouple, a thin thermocouple should be contacted with the specimen to measure the specimen temperature with minimal uncertainty. If the thermocouple junction cannot be allowed to contact the specimen because of chemical reaction with the specimen, or because it interrupts the setting of the specimen, or because of the system design, the tip should be placed as close as practical to the specimen in the same plane.

### 4.4 Detector for measuring transient temperature rise of rear face of the specimen

The transient temperature rise curve on the rear face of the specimen shall be observed with a non-contact radiation thermometer or a radiation detector. The frequency response of the detector and its associated electronics should be faster than 10 kHz. The target diameter of the radiation detector should be smaller than 50 % of the diameter for disk specimens, or 50 % of the shortest side-length for square and rectangular specimens.

### 4.5 Environment for measurements

Measurements may be performed under open air, under an inert gas atmosphere, or under vacuum at room temperature. For higher temperature measurements, an appropriate inert atmosphere or vacuum shall be used, when necessary, to protect furnace parts and specimen holders from oxidation and to protect the specimen and its coating from structure/phase changes and compatibility problems.

### 4.6 Temperature control unit

For higher temperature measurements, the specimen should be kept at a stable temperature by electric heaters before pulse heating. Drift and fluctuation of the temperature should be less than 0,01 K/s.

### 4.7 Data acquisition unit

The transient detector signal should be amplified and converted to the digital signal using a digital oscilloscope or an AD converter which is input to a personal computer for computation of the thermal diffusivity. The frequency response of the amplifier and the AD conversion should be faster than 10 kHz. The resolution of the AD conversion should be larger than 10 bits, more than 1000 data points should be sampled with the sampling time faster than 1 % of the half rise-time " $t_{1/2}$ ".

## 5 Specimen

### 5.1 Shape and dimension of specimens

The specimen shall be a flat plate of circular, square or rectangular shape. The specimen diameter or side shall be between 5 mm and 15 mm.

The specimen thickness shall be chosen to be as follows:

- a) thicker than 0,5 mm and thinner than 5 mm;
- b) sufficiently thick that the  $t_{1/2}$  value is larger than 5 times the pulse width.

The uniformity of the specimen thickness shall be smaller than 1,0 %.

## 5.2 Coating on the specimen

If the specimen does not have a high absorption coefficient for the heating laser beam or a high emissivity for radiative temperature detection, the surfaces of the specimen shall be coated with a thin, opaque, preferably black layer. The coating shall be dense enough to prevent penetration of the laser beam or thermal radiation at the observed wavelength, and should be resistive against laser pulse heating at high temperatures. Coating thickness should be a minimum commensurate with excluding directly transmitted laser pulse.

NOTE Suitable coatings for many ceramic materials include evaporated, sputtered carbon or sprayed colloidal graphite. If the test specimen reacts with carbon at high temperatures, a metal coating, such as platinum, gold or nickel may alternatively be used. The surface of the test specimen may, with advantage, be roughened to improve adhesion of the coating. The coating thickness dependence must be evaluated for the observed thermal diffusivity, if the contribution of coatings is not negligible.

## 5.3 Reference specimen

Reference specimens can be used to evaluate uncertainty of thermal diffusivity measurements by a laser flash apparatus. The uncertainty is obtained as the difference between the measured value and the reference value of thermal diffusivity of the reference specimen.

NOTE There are no certified reference materials for thermal diffusivity measurements authorized by national or international organizations yet, although several materials are used as such (see Annex E).

Care should be taken in the use of these references to ensure that the half rise-time and the thermal diffusivity value are similar to those of the test materials.

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## 6 Measurement procedure (standards.iteh.ai)

The specimen shall be measured under the following procedures:

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### 6.1 Measurement of specimen thickness

Measure the thickness of the specimen to an accuracy of 0,5 % or better, using a micrometer in accordance with ISO 3611.

### 6.2 Surface treatment

Carry out the surface treatment in accordance with 5.2.

### 6.3 Determination of flash time of the laser pulse and the chronological profile of the laser pulse

The chronological trace of the laser pulse versus the same trigger signal to initiate laser flash thermal diffusivity measurements shall be observed. If the FWHM of the laser pulse duration is larger than 1 % of the half rise-time, correction for the finite pulse time shall be made following one of the procedures stated in Annex B.

### 6.4 Temperature and atmosphere control

Insert the test specimen in the apparatus and position the thermocouples. The atmosphere should be such that the specimen is not subjected to any chemical change under the measured temperature range.

### 6.5 Stability of specimen temperature

The specimen temperature shall be controlled with drift smaller than 0,01 K/s.

## 6.6 Energy of pulse heating

Irradiate the specimen with the laser pulse at an intensity of as low energy as possible, commensurate with an acceptable noise level.

NOTE Refer to Annex D about nonlinearity of spectral radiance on temperature.

## 6.7 Measurement temperature

Record the measurement temperature as  $T_0 + \Delta T_{\max}$ , where  $T_0$  is the initial steady-state temperature and  $\Delta T_{\max}$  is the maximum temperature rise of the specimen recorded by the thermocouple in contact with the specimen or the calibrated radiation thermometer.

NOTE A thermocouple below 0,15 mm in diameter, which is directly contacted to the rear or side surface of a specimen mechanically or with a paste, is preferable to estimate  $\Delta T_{\max}$ .

## 6.8 Record

The transient temperature curve should be recorded for a duration at least until 10 times the half-rise-time, in order to make reliable evaluation of measurements, including heat-loss correction and evaluation of nonuniform heating effect.

## 7 Data analysis

### 7.1 Calculation based on the half-rise-time method

The standard algorithm to calculate thermal diffusivity from the laser flash method is the half-rise-time method, in which the analytical equation is fitted to the transient temperature curve at  $t$ , the height of a half of maximum temperature rise of the transient temperature or radiance response curve above the base line " $\Delta T_{\max} / 2$ " over the half-rise-time.

If the measurement is valid when made under the above-mentioned ideal initial and boundary conditions, the thermal diffusivity,  $\alpha$ , is represented by the following equation based on the half-rise-time method:

$$\alpha = \frac{0,1388 d^2}{t_{1/2}} \quad (1)$$

where  $t_{1/2}$  is the time delay when the temperature of the rear face reaches one-half of the maximum temperature rise,  $\Delta T_{\max}$ , after the front face was heated by the laser pulse.

### 7.2 Criteria for applicability of the half-rise-time method

In order that the rise-time can be validly applied, the following initial and boundary conditions must be satisfied:

- The duration of the laser pulse is short, compared with the characteristic time of heat diffusion (FWHM < 1 % of  $t_{1/2}$ ).
- The front face of the specimen is uniformly heated by the light pulse.
- The specimen is adiabatic during the period of measurement after the light pulse heating.
- The specimen is uniform (in geometry) and is homogeneous.
- The specimen is opaque (nontransparent and nontranslucent) to the light pulse and to thermal radiation.

If these conditions are satisfied, the heat flow becomes one-dimensional and the temperature of the rear face of the specimen changes according to an analytical equation (See Annex A).

The thermal diffusivity value shall be determined by fitting this equation to the observed transient temperature curve. Theoretically, if the measurement is made under the above-mentioned ideal conditions, the calculated thermal diffusivity value should be independent of the position along the transient curves. Therefore, any point on the transient temperature curve can be analyzed to yield the thermal diffusivity,  $\alpha$ . This will be given by Equation (2) as follows;

$$\alpha = \frac{K_x d^2}{t_x} \tag{2}$$

where

$d$  is the specimen thickness, in metres;

$t_x$  is the time for the specimen rear face to reach a fraction of the maximum temperature rise, in seconds (see Table 1);

$x$  is the percentage of the maximum rise in temperature;

$K_x$  is a constant relating  $\alpha$  to  $d$  and  $t_x$ , in the case of ideal measurements.

Calculate the thermal diffusivity at fractional temperature rises other than  $t_{1/2}$ . If the values at  $t_{0,3}$ ,  $t_{0,5}$  and  $t_{0,7}$  calculated using the relevant values of  $K_x$  in Table 1 are all within  $\pm 2\%$  then it can be assumed that the half-rise-time method is applicable without any correction. If the spread of thermal diffusivity values so calculated is greater than  $\pm 2\%$ , the possibility of non-ideal initial and/or boundary conditions, imperfect design and/or operation of the laser flash apparatus, or problems associated with the specimen, must be considered.

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**Table 1 — Values of constant  $K_x$  for a range of transient times**

$x$ %	$K_x$	$t_x$
10	0,0662	$t_{0,1}$
20	0,0843	$t_{0,2}$
30	0,1012	$t_{0,3}$
40	0,1190	$t_{0,4}$
50	0,1388	$t_{1/2}$
60	0,1622	$t_{0,6}$
70	0,1919	$t_{0,7}$
80	0,2332	$t_{0,8}$
90	0,3036	$t_{0,9}$